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(37 CFR §1.98(b))

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/B.M./	AL	2002-096034	04/02/2002	Japan			x	
	AM	06-190625	07/12/1994	Japan			x	<u> </u>
	AN	09-085573	03/31/1997	Japan			х	
	AO	05-16078	03/02/1993	Japan			х	
	AP	51-122479	10/04/1976	Japan				Х
	AQ	62-246455	10/27/1987	Japan				x
	AR	2-15244	01/30/1990	Japan				Х
V	AS	62-138546	09/01/1987	Japan				Х

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15682-017US1	Application No. 10/566,921	
1	closure Statement pplicant	Applicant Nobuo Imamura et al.		
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